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March 2016

# FDP51N25 / FDPF51N25 N-Channel UniFET<sup>TM</sup> MOSFET 250 V, 51 A, 60 m $\Omega$

#### **Features**

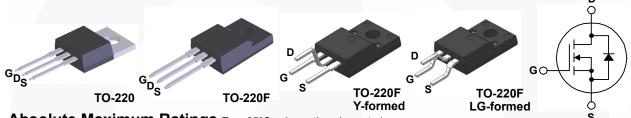
- $R_{DS(on)}$  = 48  $m\Omega(Typ.)$  @  $V_{GS}$  = 10 V,  $I_D$  = 25.5 A
- Low Gate Charge (Typ. 55 nC)
- Low Crss (Typ. 63 pF)

## **Applications**

- PDP TV
- Lighting
- · Uninterruptible Power Supply
- · AC-DC Power Supply

#### Description

UniFET<sup>TM</sup> MOSFET is Fairchild Semiconductor's high voltage MOSFET family based on planar stripe and DMOS technology. This MOSFET is tailored to reduce on-state resistance, and to provide better switching performance and higher avalanche energy strength. This device family is suitable for switching power converter applications such as power factor correction (PFC), flat panel display (FPD) TV power, ATX and electronic lamp ballasts.



**Absolute Maximum Ratings** T<sub>C</sub> = 25°C unless otherwise noted.

| Symbol                           | Para  | nmeter  | FDP51N25   | FDPF51N25<br>FDPF51N25YDTU<br>FDPF51N25RDTU | Unit      |
|----------------------------------|---|---|------------|---|-----------|
| $V_{DSS}$                        | Drain-Source Voltage  |   |            | V   |           |
| I <sub>D</sub>                   | Drain Current   | - Continuous (T <sub>C</sub> = 25°C)<br>- Continuous (T <sub>C</sub> = 100°C) | 51<br>30   | 51*<br>30*                                  | A<br>A    |
| I <sub>DM</sub>                  | Drain Current   | - Pulsed (Note 1)   | 204        | 204*  | Α         |
| V <sub>GSS</sub>                 | Gate-Source voltage   |   |            | V   |           |
| E <sub>AS</sub>                  | Single Pulsed Avalanche Energy (Note 2)   |   |            | mJ  |           |
| I <sub>AR</sub>                  | Avalanche Current (Note 1)  |   |            | Α   |           |
| E <sub>AR</sub>                  | Repetitive Avalanche Energy (Note 1)  |   |            | mJ  |           |
| V <sub>ISO</sub>                 | Insulation with stand voltage (RMS) from all three leads to external heat sink (t=0.3sec; $T_C = 25^{\circ}C$ ) |   | N/A        | 2500  | V         |
| dv/dt                            | Peak Diode Recovery dv/dt   | (Note 3)  | 4.5        |   | V/ns      |
| $P_D$                            | Power Dissipation   | (T <sub>C</sub> = 25°C)<br>- Derate Above 25°C                                | 320<br>3.7 | 38<br>0.3                                   | W<br>W/°C |
| T <sub>J,</sub> T <sub>STG</sub> | Operating and Storage Temperature Range   |   | -55        | °C  |           |
| T <sub>L</sub>                   | Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds  |   |            | °C  |           |

<sup>\*</sup>Drain current limited by maximum junction temperature.

#### **Thermal Characteristics**

| Symbol          | Parameter                                     | FDP51N25 | FDPF51N25<br>FDPF51N25YDTU<br>FDPF51N25RDTU | Unit |
|-----------------|---|----------|---|------|
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case, Max.    | 0.39     | 3.3   | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient, Max. | 62.5     | 62.5  | °C/W |

# **Package Marking and Ordering Information**

| Part Number   | Top Mark  | Package                | Packing Method | Reel Size | Tape Width | Quantity |
|---------------|-----------|------------------------|----------------|-----------|------------|----------|
| FDP51N25      | FDP51N25  | TO-220                 | Tube           | N/A       | N/A        | 50 units |
| FDPF51N25     | FDPF51N25 | TO-220F                | Tube           | N/A       | N/A        | 50 units |
| FDPF51N25YDTU | FDPF51N25 | TO-220F<br>(Y-formed)  | Tube           | N/A       | N/A        | 50 units |
| FDPF51N25RDTU | FDPF51N25 | TO-220F<br>(LG-formed) | Tube           | N/A       | N/A        | 50 units |

# **Electrical Characteristics** $T_C = 25^{\circ}C$ unless otherwise noted.

| Symbol                                  | Parameter   | Conditions  | Min. | Тур.  | Max.    | Unit                     |
|---|---|---|------|-------|---------|--------------------------|
| Off Charac                              | teristics   |   |      |       |         |                          |
| BV <sub>DSS</sub>                       | Drain-Source Breakdown Voltage                        | V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA, T <sub>J</sub> = 25 °C                                  |      |       |         | V                        |
| ΔBV <sub>DSS</sub><br>/ ΔT <sub>J</sub> | Breakdown Voltage Temperature<br>Coefficient          | I <sub>D</sub> = 250 μA, Referenced to 25°C   |      | 0.25  |         | V/°C                     |
| I <sub>DSS</sub>                        | Zero Gate Voltage Drain Current                       | $V_{DS} = 250 \text{ V}, V_{GS} = 0 \text{ V}$<br>$V_{DS} = 200 \text{ V}, T_{C} = 125^{\circ}\text{C}$ |      |       | 1<br>10 | μ <b>Α</b><br>μ <b>Α</b> |
| I <sub>GSSF</sub>                       | Gate-Body Leakage Current, Forward                    | V <sub>GS</sub> = 30 V, V <sub>DS</sub> = 0 V   |      |       | 100     | nA                       |
| I <sub>GSSR</sub>                       | Gate-Body Leakage Current, Reverse                    | V <sub>GS</sub> = -30 V, V <sub>DS</sub> = 0V   |      |       | -100    | nA                       |
| On Charac                               | teristics   |   | (    |       |         | ļ                        |
| V <sub>GS(th)</sub>                     | Gate Threshold Voltage                                | $V_{DS} = V_{GS}, I_{D} = 250 \mu A$  | 3.0  |       | 5.0     | V                        |
| R <sub>DS(on)</sub>                     | Static Drain-Source<br>On-Resistance                  | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 25.5 A   |      | 0.048 | 0.060   | Ω                        |
| 9 <sub>FS</sub>                         | Forward Transconductance                              | V <sub>DS</sub> = 40 V, I <sub>D</sub> = 25.5 A   | \    | 43    |         | S                        |
| Dynamic C                               | Characteristics                                       |   |      |       |         |                          |
| C <sub>iss</sub>                        | Input Capacitance                                     | V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V,<br>f = 1 MHz   |      | 2620  | 3410    | pF                       |
| C <sub>oss</sub>                        | Output Capacitance                                    |   |      | 530   | 690     | pF                       |
| C <sub>rss</sub>                        | Reverse Transfer Capacitance                          |   |      | 63    | 90      | pF                       |
| Switching                               | Characteristics                                       |   |      |       |         |                          |
| t <sub>d(on)</sub>                      | Turn-On Delay Time                                    | $V_{DD} = 125 \text{ V, } I_D = 51 \text{ A,}$ $V_{GS} = 10 \text{ V, } R_G = 25 \Omega$ (Note 4)       |      | 62    | 135     | ns                       |
| t <sub>r</sub>                          | Turn-On Rise Time                                     |   |      | 465   | 940     | ns                       |
| t <sub>d(off)</sub>                     | Turn-Off Delay Time                                   |   |      | 98    | 205     | ns                       |
| t <sub>f</sub>                          | Turn-Off Fall Time                                    |   |      | 130   | 270     | ns                       |
| Qg                                      | Total Gate Charge                                     | $V_{DS} = 200 \text{ V}, I_D = 51 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note 4)                          |      | 55    | 70      | nC                       |
| Q <sub>gs</sub>                         | Gate-Source Charge                                    |   |      | 16    |         | nC                       |
| Q <sub>gd</sub>                         | Gate-Drain Charge                                     |   |      | 27    |         | nC                       |
| Drain-Sou                               | rce Diode Characteristics and Maximur                 | n Ratings   |      |       |         |                          |
| I <sub>S</sub>                          | Maximum Continuous Drain-Source Diode Forward Current |   |      |       | 51      | Α                        |
| I <sub>SM</sub>                         | Maximum Pulsed Drain-Source Diode Forward Current     |   |      |       | 204     | Α                        |
| $V_{SD}$                                | Drain-Source Diode Forward Voltage                    | V <sub>GS</sub> = 0 V, I <sub>S</sub> = 51 A  |      |       | 1.4     | ٧                        |
| t <sub>rr</sub>                         | Reverse Recovery Time                                 | V <sub>GS</sub> = 0 V, I <sub>S</sub> = 51 A,   |      | 178   |         | ns                       |
| Q <sub>rr</sub>                         | Reverse Recovery Charge                               | dI <sub>F</sub> /dt =100 A/μs   |      | 4.0   |         | μС                       |

- 1. Repetitive rating: pulse-width limited by maximum junction temperature.
- 2. L = 0.68 mH, I  $_{AS}$  = 51 A, V  $_{DD}$  = 50 V, R  $_{G}$  = 25  $\Omega$  starting T  $_{J}$  = 25° C. 3. I  $_{SD}$   $\leq$  51 A, di/dt  $\leq$  200 A/ $\mu$ s, V  $_{DD}$   $\leq$  BV  $_{DSS}$ , starting T  $_{J}$  = 25° C.
- 4. Essentially independent of operating temperature typical characteristics.

## **Typical Performance Characteristics**

Figure 1. On-Region Characteristics

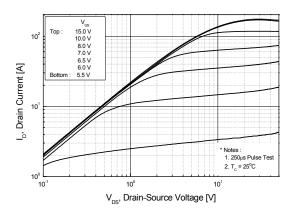


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

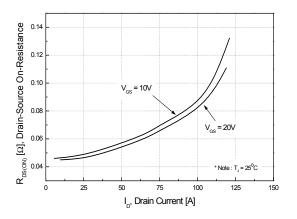


Figure 5. Capacitance Characteristics

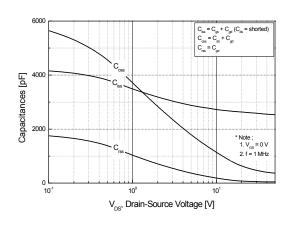


Figure 2. Transfer Characteristics

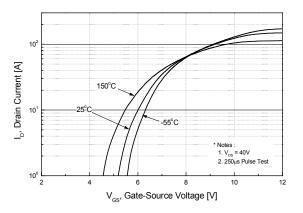


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperatue

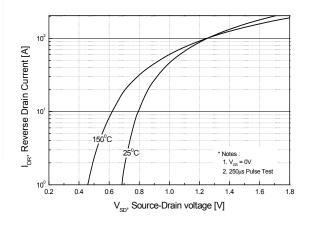
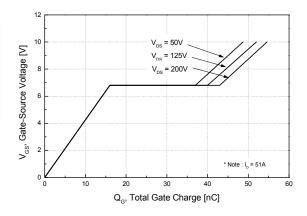


Figure 6. Gate Charge Characteristics



# Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

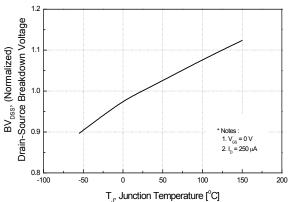


Figure 9-1. Maximum Safe Operating Area for FDP51N25



Figure 9-2. Maximum Safe Operating Area for FDPF51N25 / FDPF51N25YDTU

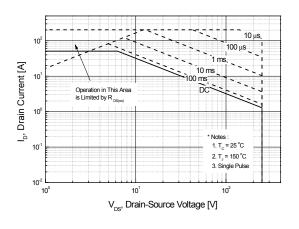
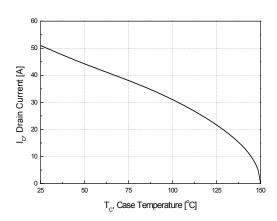


Figure 10. Maximum Drain Current vs. Case Temperature



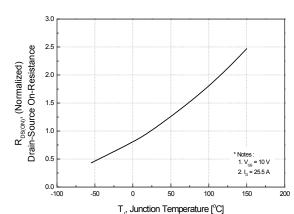
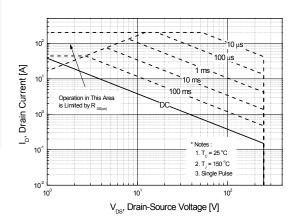


Figure 8. On-Resistance Variation

vs. Temperature



## **Typical Performance Characteristics** (Continued)

Figure 11-1. Transient Thermal Response Curve for FDP51N25

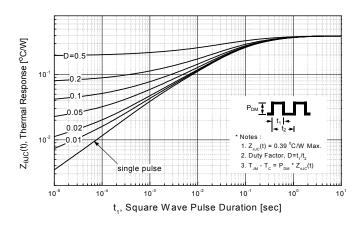
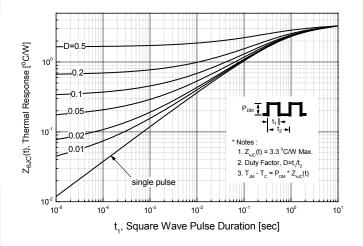


Figure 11-2. Transient Thermal Response Curve for FDPF51N25 / FDPF51N25YDTU



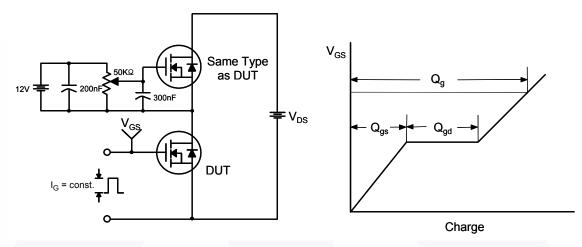


Figure 12. Gate Charge Test Circuit & Waveform

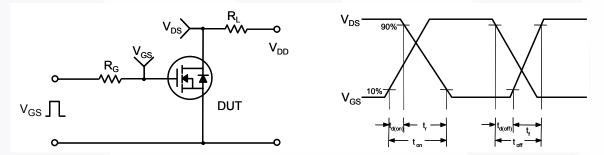


Figure 13. Resistive Switching Test Circuit & Waveforms

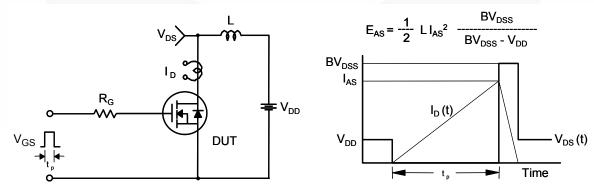


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms

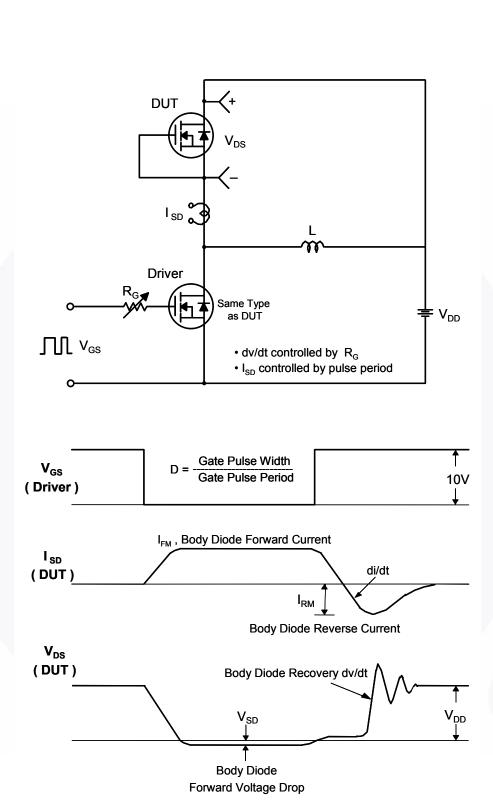
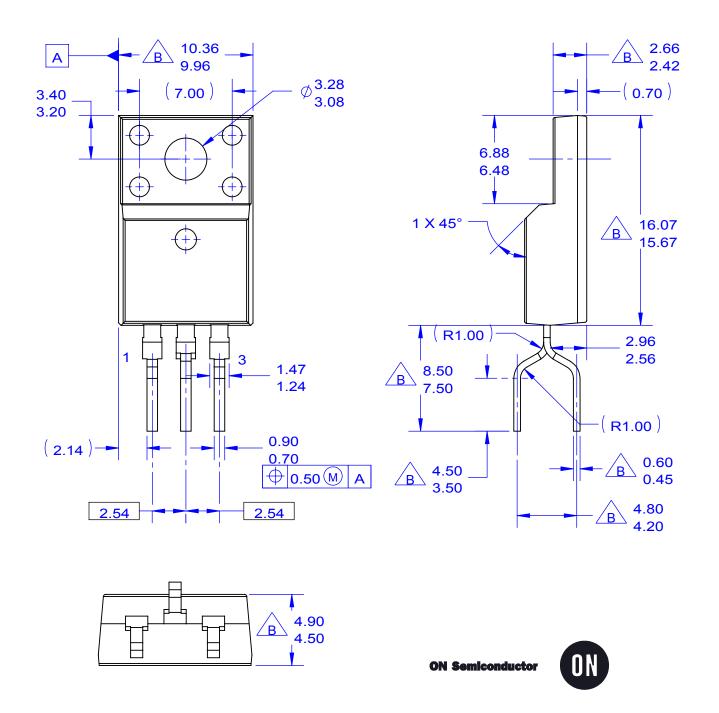


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

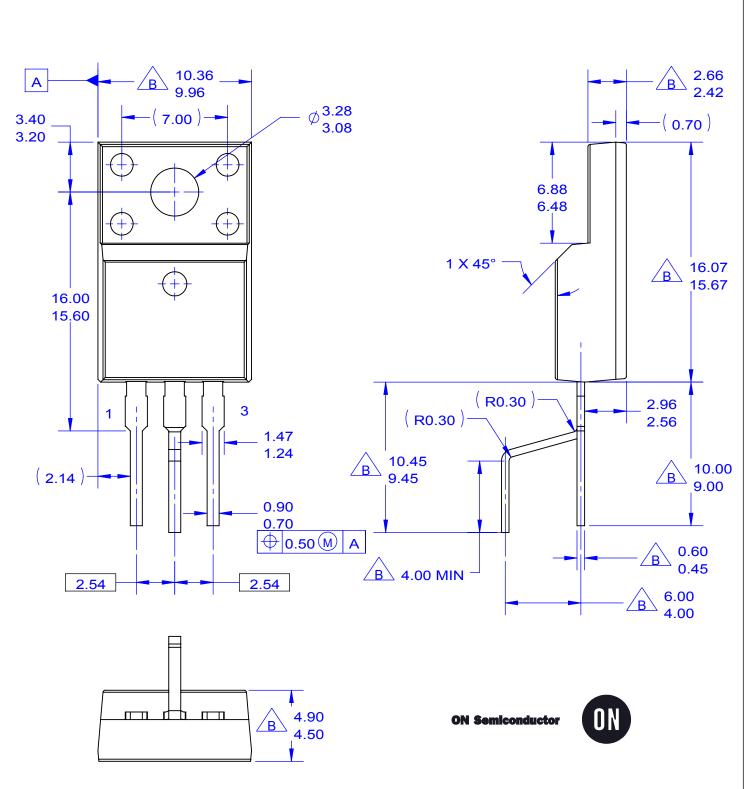


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- F. DRAWING FILE NAME: TO220N03REV2

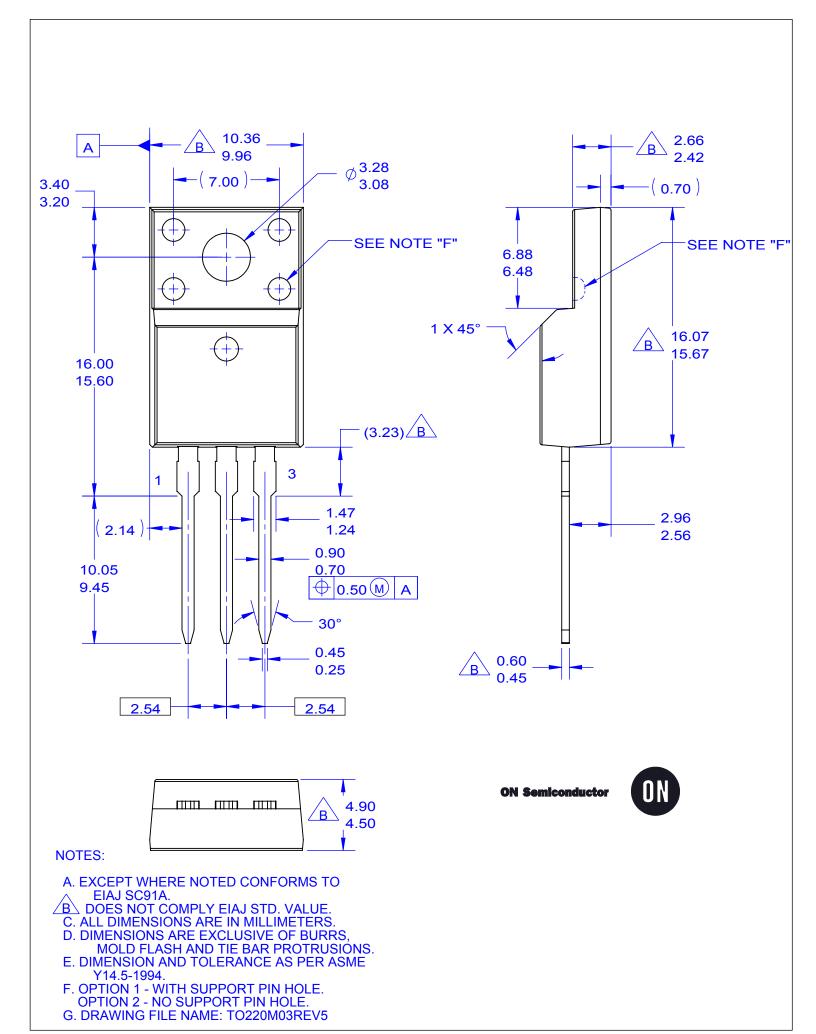


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